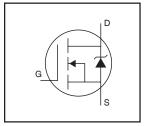
# International Rectifier

# AUIRF3305

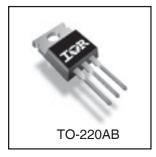
## HEXFET® Power MOSFET

### **Features**

- Advanced Planar Technology
- Low On-Resistance
- Dynamic dV/dT Rating
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated
- Repetitive Avalanche Allowed up to Tjmax
- · Lead-Free, RoHS Compliant
- Automotive Qualified \*



V <sub>(BR)DSS</sub>	55V
R <sub>DS(on)</sub> max.	8m $\Omega$
I <sub>D</sub>	140A



,		
G	D	S
Gate	Drain	Source

## Description

Specifically designed for Automotive applications, this cellular design of HEXFET® Power MOSFETs utilizes the latest processing techniques to achieve low on-resistance per silicon area. This benefit combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in Automotive and a wide variety of other applications.

## **Absolute Maximum Ratings**

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature  $(T_A)$  is 25°C, unless otherwise specified.

	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	140	
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	99	А
I <sub>DM</sub>	Pulsed Drain Current ①	560	
P <sub>D</sub> @T <sub>C</sub> = 25°C	Power Dissipation	330	W
	Linear Derating Factor	2.2	W/°C
$V_{GS}$	Gate-to-Source Voltage	± 20	V
E <sub>AS</sub>	Single Pulse Avalanche Energy(Thermally limited) ②	470	mJ
E <sub>AS</sub> (Tested )	Single Pulse Avalanche Energy Tested Value © 6	860	IIIJ
I <sub>AR</sub>	Avalanche Current ①	See Fig.12a, 12b, 15, 16	А
E <sub>AR</sub>	Repetitive Avalanche Energy ®		mJ
TJ	Operating Junction and	-55 to + 175	
T <sub>STG</sub>	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds(1.6mm from case)	300	
	Mounting Torque, 6-32 or M3 screw	10 lbf•in (1.1N•m)	

## **Thermal Resistance**

	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case ⑦		0.45	
$R_{\theta CS}$	Case-to-Sink, Flat, Greased Surface	0.50		°C/W
$R_{\theta JA}$	Junction-to-Ambient		62	

HEXFET® is a registered trademark of International Rectifier.

<sup>\*</sup>Qualification standards can be found at http://www.irf.com/



## Static Electrical Characteristics @ T<sub>1</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	55			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient	_	0.055		V/°C	Reference to 25°C, I <sub>D</sub> = 1mA
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance			8.0	mΩ	V <sub>GS</sub> = 10V, I <sub>D</sub> = 75A ③⑧
V <sub>GS(th)</sub>	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
gfs	Forward Transconductance	41			S	V <sub>DS</sub> = 25V, I <sub>D</sub> = 75A®
I <sub>DSS</sub>	Drain-to-Source Leakage Current	_		25	μΑ	$V_{DS} = 55V, V_{GS} = 0V$
				250	1	$V_{DS} = 55V$ , $V_{GS} = 0V$ , $T_{J} = 125$ °C
I <sub>GSS</sub>	Gate-to-Source Forward Leakage	_		200	nA	V <sub>GS</sub> = 20V
	Gate-to-Source Reverse Leakage			-200	1	V <sub>GS</sub> = -20V
Q <sub>g</sub>	Total Gate Charge		100	150	0	I <sub>D</sub> = 75A ®
Dynamic Ele	ctrical Characteristics @ $T_J$ = 25°C (	unless o	otherwi	se spe	cified)	
$Q_{gs}$	Gate-to-Source Charge	+ ==	21		nC	V <sub>DS</sub> = 44V
$Q_{gd}$	Gate-to-Ordinge  Gate-to-Drain ("Miller") Charge		45		''	V <sub>GS</sub> = 10V ③
t <sub>d(on)</sub>	Turn-On Delay Time	+	16			V <sub>DD</sub> = 28V
t <sub>r</sub>	Rise Time	+	88		†	I <sub>D</sub> = 75A ®
t <sub>d(off)</sub>	Turn-Off Delay Time		43		ns	$R_G = 2.6 \Omega$
t <sub>f</sub>	Fall Time	<del> </del>	34		•	V <sub>GS</sub> = 10V ③
L <sub>D</sub>	Internal Drain Inductance	<del> </del>	4.5			Between lead,
					nH	6mm (0.25in.)
L <sub>S</sub>	Internal Source Inductance		7.5		1	from package
						and center of die contact
C <sub>iss</sub>	Input Capacitance		3650			V <sub>GS</sub> = 0V
Coss	Output Capacitance		1230		1	$V_{DS} = 25V$
C <sub>rss</sub>	Reverse Transfer Capacitance		450		pF	f = 1.0MHz
Coss	Output Capacitance	T	4720		Ī	$V_{GS} = 0V, V_{DS} = 1.0V, f = 1.0MHz$
C <sub>oss</sub>	Output Capacitance	T	930		1	$V_{GS} = 0V, V_{DS} = 44V, f = 1.0MHz$

## **Diode Characteristics**

	Parameter	Min.	Тур.	Max.	Units	Conditions
I <sub>S</sub>	Continuous Source Current			75		MOSFET symbol
	(Body Diode)				Α	showing the
I <sub>SM</sub>	Pulsed Source Current			560		integral reverse
	(Body Diode) ①					p-n junction diode.
$V_{SD}$	Diode Forward Voltage			1.3	V	$T_J = 25$ °C, $I_S = 75A$ ®, $V_{GS} = 0V$ ③
t <sub>rr</sub>	Reverse Recovery Time		57	86	ns	$T_J = 25$ °C, $I_F = 75A$ $\$$ , $V_{DD} = 28V$
$Q_{rr}$	Reverse Recovery Charge		130	190	nC	di/dt = 100A/µs ③
t <sub>on</sub>	Forward Turn-On Time	Intrinsic t	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)			

1490

### Notes:

Coss eff.

① Repetitive rating; pulse width limited by max. junction temperature.

Effective Output Capacitance

- $V_{\text{GS}}$  =10V. Part not recommended for use above this value.
- $\ensuremath{\mathfrak{G}}$   $C_{oss}$  eff. is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$  .
- avalanche performance.
- © This value determined from sample failure population. 100% tested to this value in production.

 $V_{GS} = 0V, V_{DS} = 0V \text{ to } 44V \oplus$ 

- ® All AC and DC test conditions based on former package limited current of 75A.

## Qualification Information<sup>†</sup>

		Automotive				
		(per AEC-Q101) <sup>††</sup>				
		Comments: This part number(s) passed Automotive qualification. IR's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.				
		3L-TO-220 N/A				
	Machine Model Human Body Model	Class M4(425V)				
		(per AEC-Q101-002)				
FOD		Class H2 (4000V)				
ESD		(per AEC-Q101-001)				
	Charried Davies Madel	Class C5 (1125V)				
	Charged Device Model	(per AEC-Q101-005)				
RoHS Compliant		Yes				

<sup>†</sup> Qualification standards can be found at International Rectifier's web site: http://www.irf.com/

<sup>††</sup> Exceptions to AEC-Q101 requirements are noted in the qualification report.

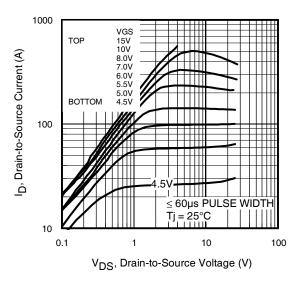


Fig 1. Typical Output Characteristics

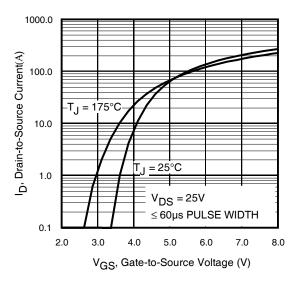


Fig 3. Typical Transfer Characteristics

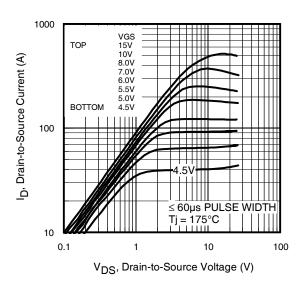


Fig 2. Typical Output Characteristics

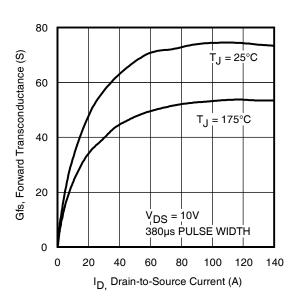
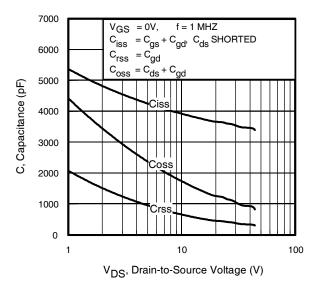
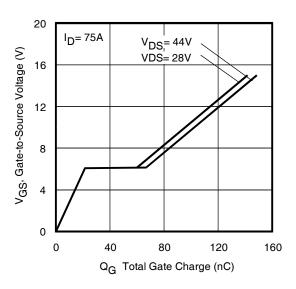


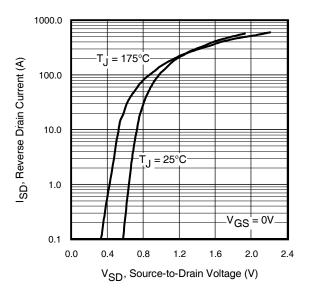
Fig 4. Typical Forward Transconductance Vs. Drain Current



**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage



**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage



**Fig 7.** Typical Source-Drain Diode Forward Voltage

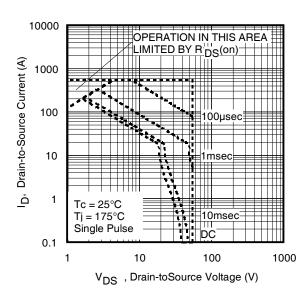
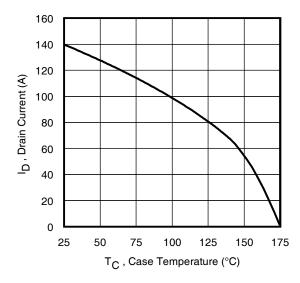
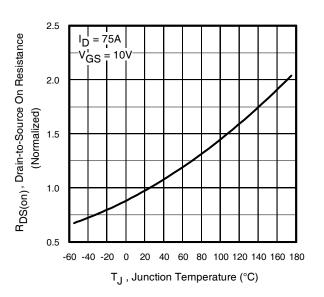


Fig 8. Maximum Safe Operating Area







**Fig 10.** Normalized On-Resistance Vs. Temperature

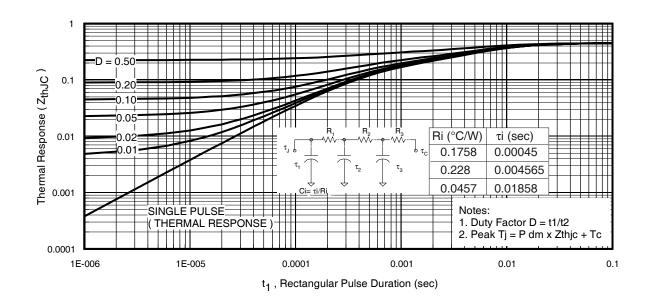


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

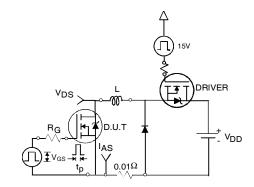


Fig 12a. Unclamped Inductive Test Circuit

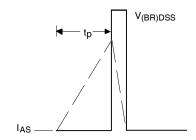


Fig 12b. Unclamped Inductive Waveforms

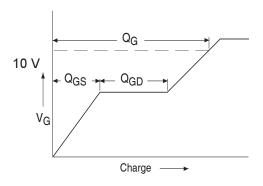


Fig 13a. Basic Gate Charge Waveform

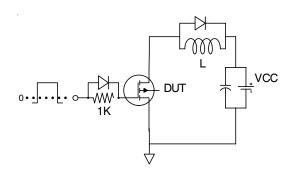


Fig 13b. Gate Charge Test Circuit

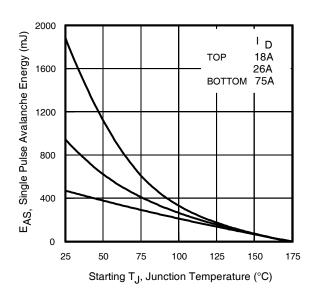


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

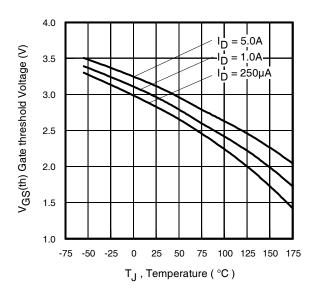


Fig 14. Threshold Voltage Vs. Temperature

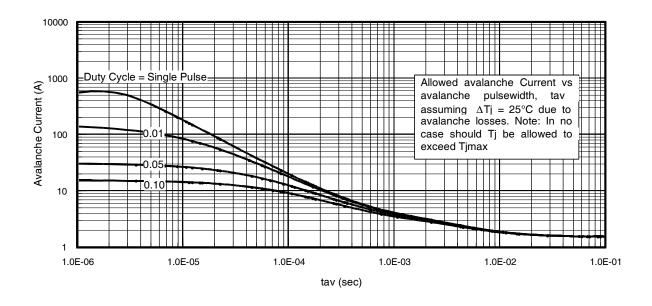
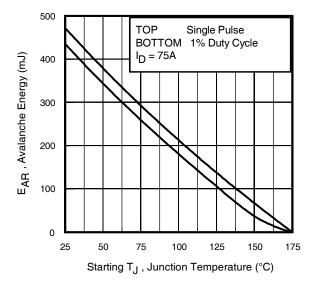


Fig 15. Typical Avalanche Current Vs. Pulsewidth



**Fig 16.** Maximum Avalanche Energy Vs. Temperature

# Notes on Repetitive Avalanche Curves , Figures 15, 16: (For further info, see AN-1005 at www.irf.com)

- 1. Avalanche failures assumption:
  - Purely a thermal phenomenon and failure occurs at a temperature far in excess of  $T_{jmax}$ . This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long  $asT_{jmax}$  is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
- P<sub>D (ave)</sub> = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I<sub>av</sub> = Allowable avalanche current.
- 7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as 25°C in Figure 15, 16).

 $t_{av}$  = Average time in avalanche.

 $D = Duty cycle in avalanche = t_{av} \cdot f$ 

 $Z_{thJC}(D, t_{av})$  = Transient thermal resistance, see figure 11)

$$\begin{split} \textbf{P}_{D \; (ave)} &= 1/2 \; (\; \textbf{1.3} \cdot \textbf{BV} \cdot \textbf{I}_{av}) = \triangle \textbf{T} / \, \textbf{Z}_{thJC} \\ \textbf{I}_{av} &= 2\triangle \textbf{T} / \; [\textbf{1.3} \cdot \textbf{BV} \cdot \textbf{Z}_{th}] \\ \textbf{E}_{AS \; (AR)} &= \textbf{P}_{D \; (ave)} \cdot \textbf{t}_{av} \end{split}$$

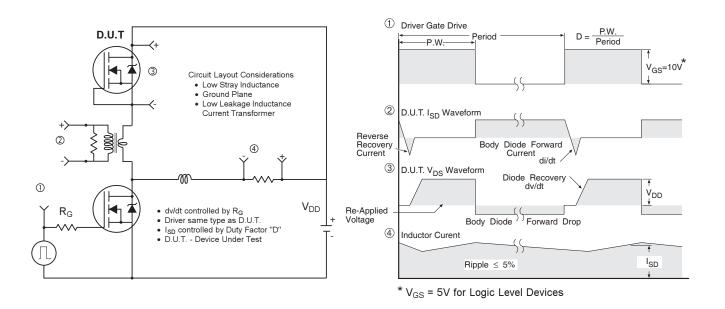


Fig 17. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

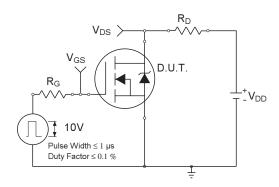


Fig 18a. Switching Time Test Circuit

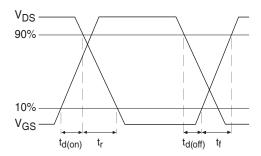
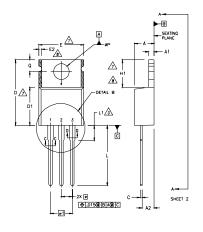
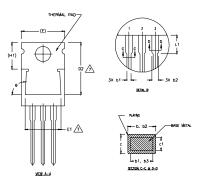


Fig 18b. Switching Time Waveforms

## TO-220AB Package Outline

Dimensions are shown in millimeters (inches)





#### NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5 M- 1994.
- DIMENSIONS ARE SHOWN IN INCHES [MILLIMETERS].
- LEAD DIMENSION AND FINISH UNCONTROLLED IN LI
- DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH
  SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.

DIMENSIONS

DIMENSION b1 & c1 APPLY TO BASE METAL ONLY.

- CONTROLLING DIMENSION: INCHES, THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS E,H1,D2 & E1
- DIMENSION E2 X H1 DEFINE A ZONE WHERE STAMPING AND SINGULATION IRREGULARITIES ARE ALLOWED.

#### LEAD ASSIGNMENTS

## HEXFET

- 2.- DRAIN 3.- SOURCE

#### IGBTs, CoPACK

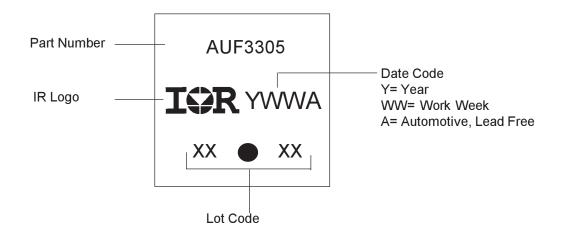
1.- GATE 2.- COLLECTOR 3.- EMITTER

## DIODES

1.- ANODE/OPEN 2.- CATHODE 3.- ANODE

SYMBOL	MILLIMETERS		INC	HES		
	MIN.	MAX.	MIN.	MAX.	NOTES	
Α	3.56	4,82	.140	.190		
A1	0.51	1.40	.020	.055		
A2	2.04	2.92	.080	.115		
b	0.38	1,01	.015	.040		
ь1	0.38	0.96	.015	.038	5	
b2	1.15	1,77	.045	.070		
b3	1.15	1.73	.045	.068		
С	0.36	0.61	.014	.024		
c1	0.36	0.56	.014	.022	5	
D	14.22	16,51	.560	.650	4	
D1	8.38	9.02	.330	.355		
D2	12.19	12.88	.480	.507	7	
Ε	9.66	10.66	.380	.420	4,7	
E1	8.38	8.89	.330	.350	7	
е	2,54	BSC	.100	BSC		
e1	5.08		.200	BSC		
H1	5.85	6.55	.230	.270	7,8	
L	12.70	14.73	.500	.580		
L1	-	6.35	_	.250	3	
øΡ	3,54	4,08	.139	.161		
Q	2.54	3.42	.100	.135		
Ø	90*-	-93*	90*-	-93*		

## TO-220AB Part Marking Information



## **Ordering Information**

Base part	Package Type	Standard Pack		Complete Part Number
		Form	Quantity	
AUIRF3305	TO-220	Tube	50	AUIRF3305

## **IMPORTANT NOTICE**

Unless specifically designated for the automotive market, International Rectifier Corporation and its subsidiaries (IR) reserve the right to make corrections, modifications, enhancements, improvements, and other changes to its products and services at any time and to discontinue any product or services without notice. Part numbers designated with the "AU" prefix follow automotive industry and / or customer specific requirements with regards to product discontinuance and process change notification. All products are sold subject to IR's terms and conditions of sale supplied at the time of order acknowledgment.

IR warrants performance of its hardware products to the specifications applicable at the time of sale in accordance with IR's standard warranty. Testing and other quality control techniques are used to the extent IR deems necessary to support this warranty. Except where mandated by government requirements, testing of all parameters of each product is not necessarily performed.

IR assumes no liability for applications assistance or customer product design. Customers are responsible for their products and applications using IR components. To minimize the risks with customer products and applications, customers should provide adequate design and operating safeguards.

Reproduction of IR information in IR data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. Reproduction of this information with alterations is an unfair and deceptive business practice. IR is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of IR products or serviced with statements different from or beyond the parameters stated by IR for that product or service voids all express and any implied warranties for the associated IR product or service and is an unfair and deceptive business practice. IR is not responsible or liable for any such statements.

IR products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or in other applications intended to support or sustain life, or in any other application in which the failure of the IR product could create a situation where personal injury or death may occur. Should Buyer purchase or use IR products for any such unintended or unauthorized application, Buyer shall indemnify and hold International Rectifier and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that IR was negligent regarding the design or manufacture of the product.

IR products are neither designed nor intended for use in military/aerospace applications or environments unless the IR products are specifically designated by IR as military-grade or "enhanced plastic." Only products designated by IR as military-grade meet military specifications. Buyers acknowledge and agree that any such use of IR products which IR has not designated as military-grade is solely at the Buyer's risk, and that they are solely responsible for compliance with all legal and regulatory requirements in connection with such use.

IR products are neither designed nor intended for use in automotive applications or environments unless the specific IR products are designated by IR as compliant with ISO/TS 16949 requirements and bear a part number including the designation "AU". Buyers acknowledge and agree that, if they use any non-designated products in automotive applications, IR will not be responsible for any failure to meet such requirements

For technical support, please contact IR's Technical Assistance Center http://www.irf.com/technical-info/

## **WORLD HEADQUARTERS:**

233 Kansas St., El Segundo, California 90245 Tel: (310) 252-7105

# **Mouser Electronics**

**Authorized Distributor** 

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

Infineon:
AUIRF3305